Proced

equotip®

Portable Hardness Testing Using Leeb and Portable Rockwell





The All-In-One Hardness Testing Solution





Introducing the New Generation Equotip 550 Touchscreen Unit

Protected Hardware Connections

Probe connector, USB host, USB device and Ethernet



Elaborated User InterfaceDesigned by industry experts for smooth operation

Touchscreen Features

For simplified and improved usability on high resolution display

Special Housing

Designed to be used on-site and in harsh environments (IP 54)

Personalized Screens Arrange the view

Arrange the view according to your needs



Display	7" color display 800x480 pixels
Memory	Internal 8 GB flash memory
Regional Settings	Metric and Imperial units, multi-language and timezone supported
Power Input	12 V +/-25 % / 1.5 A
Dimensions	250 x 162 x 62 mm
Weight	About 1525 g (incl. Battery)
Battery	Lithium Polymer, 3.6 V, 14.0 Ah

Battery Lifetime	> 8 h (in standard operating mode)
Humidity	< 95 % RH, non condensing
Operating Temperature	0 °C – 30 °C (Charging*, instrument on) 0 °C – 40 °C (Charging*, instrument off) -10 °C – 50 °C (Non-charging)
IP Classification	IP 54
Certification	CE
*charging equipment	is for indoor use only (no IP classification)

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Unique Features - Outstanding Advantages

Equotip 550 takes advantage of a new generation full color, dual processor Touchscreen Unit with enhanced software capabilities. The instrument offers a unique range of functions which ultimately help speed up on-site and laboratory inspections and analysis.



More Flexibility



Modular Concept

Flexible configuration for various industry applications with a wide range of probes and accessories



Custom Reports

Modular generator allows customized measurement reports

Improved Performance



Combined Method

Automatic on-site correlation of Leeb to Portable Rockwell true indention hardness value



Conversion Curves

Enhanced Quality Assurance

Create, edit and verify material conversion curves directly on the instrument

Increased Efficiency



Guiding Wizards

Predefined workflows to increase process reliability and to improve measurement precision



Interactive Guides

On-screen notifications to obtain the most relevant settings for your application



Automatic Verification

Step by step verification in line with ISO 16859 and ASTM A956



Automation Option

Integration of NDT automation into quality management systems and automated testing environments



Covering Broad Hardness Testing Applications

Equotip 550 comes loaded with interactive wizards handpicked for specific industry applications in order to increase reliability and to assure precise measurements. A special new feature is the automatic combination of measurement methods which extends the scope of the Equotip 550 to a large area of use.

		Recommended Test Methods		
Oil & Gas		Leeb	Portable Rockwell	Combined*
	Weld, Base Material & HAZ			•
	Pressure Vessels		•	
794 69	Flanges	•	•	•
	Pipes		•	•
	Wellhead Equipment		•	•
Automotive				
TO A COMMENT OF THE PARTY OF TH	Engine Blocks	•		
2 2 2	Shafts	•	•	
	Panels		•	•
	Gears	•		
10/10/10/10	Brake Systems	•		
Aerospace				
The state of the s	Turbine Blades		•	•
	Casings / Housings		•	
	Panels		•	
	Cast Objects	•		
E	Landing Gears	•	•	
Manufacturing and Machinery				
	Roll Testing	•	•	
C-C-	Coils		•	
	Wedge Tightness	•		
	Heat Treatment / Casting	•		
	Wires		•	

*Automatically correlating the Leeb value with the Portable Rockwell measurement. For cross-reference manual verification is always possible.











Standards

ISO EN 16859

50156

9378

(publication upcoming)

GB/T 17394

DIN

JB/T

Guidelines ASME CRTD-91

99.12, 99.13, 99.36

Wide Measurement Range

Leeb impact devices are best suited for on-site testing of heavy, large or already installed parts.



Impact Devices & Accessories

Proceq offers a wide variety of impact devices along with support rings to serve most hardness testing requirements.



Broad Hardness Scales Coverage

The measurements are automatically converted to all common hardness scales (HV, HB, HRC, HRB, HRA, HS) as required.



Test Blocks Portfolio

Extensive range of precise hardness test blocks available for each impact device with different hardness levels for regular verification.

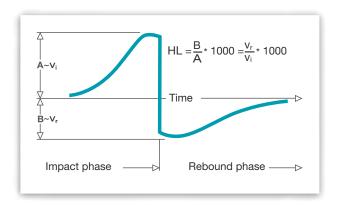


Equotip Test Blocks Flyer

The Leeb Measuring Principle

Leeb hardness principle is based on the dynamic (rebound) method. An impact body with a hard metal test tip is propelled by spring force against the surface of the test piece. Surface deformation takes place when the impact body hits the test surface, which results in loss of kinetic energy. This energy loss is detected by a comparison of velocities v, and v, when the impact body is at a precise distance from the surface for both the impact and rebound phase of the test, respectively.

Velocities are measured using a permanent magnet in the impact body that generates an induction voltage in the coil which is precisely positioned in the impact device. The detected voltage is proportional to the velocity of the impact body. Signal processing is then providing the hardness reading.



Equotip® Leeb Impact Devices

					1	1	1	1	1 1
				-	-			1	
				100		A.c.	- Au	A. Carrier	AL.
					1,1	-	-		
				D/DC	DL	S	E	G	C
				44.51	44.11	44.11	44.11	00.11	0.11
	Impact energy			11 Nmm	11 Nmm	11 Nmm	11 Nmm	90 Nmm	3 Nmm
	Indenter			Tungsten carbide	Tungsten carbide	Ceramics 3 mm	Polycrystalline diamond	Tungsten carbide	Tungsten carbide
				3 mm	2.8 mm	0	3 mm	5 mm	3 mm
	Scope			Most com-	Narrow indent-	For mea-	For mea-	Large and	For surface
				monly used probe. For the	er (probe) tip for measure-	surements in extreme hard-	surements in extreme hard-	heavy com- ponents, e.g.	hardened components,
				majority of	ment on hard	ness ranges.	ness ranges.	casts and	coatings, thin
				applications.	reach areas or	Tool steels with	Tool steels with	forged parts.	or impact-sen-
					spaces with limited access.	a high carbide content.	high carbide content.		sitive parts.
	Test blocks			<500 HLD	<710 HLDL	<815 HLS	~740 HLE	~450 HLG	~565 HLC
				~600 HLD	~780 HLDL	~875 HLS	~810 HLE	~570 HLG	~665 HLC
	Ota al anal seed	\/ialaa=	LINZ	~775 HLD	~890 HLDL	101.064	04 1011		~835 HLC
	Steel and cast	Vickers Brinell	HV HB	81-955 81-654	80-950 81-646	101-964 101-640	84-1211 83-686	90-646	81-1012 81-694
	steel	Rockwell	HRB	38-100	37-100			48-100	
			HRC HRA	20-68	21-68	22-70 61-88	20-72 61-88		20-70
		Shore	HS	30-99	31-97	28-104	29-103		30-102
		Rm N/mm ²	σ1	275-2194	275-2297	340-2194	283-2195	305-2194	275-2194
			σ2 σ3	616-1480 449-847	614-1485 449-849	615-1480 450-846	616-1479 448-849	618-1478 450-847	615-1479 450-846
	Cold work tool steel	Vickers	HV	80-900	80-905	104-924	82-1009	*	98-942
as		Rockwell	HRC	21-67	21-67	22-68	23-70		20-67
Range	Stainless steel	Vickers	HV	85-802	*	119-934	88-668	*	*
ā		Brinell Rockwell	HB HRB	85-655 46-102		105-656 70-104	87-661 49-102		
			HRC	20-62		21-64	20-64		
5	Cast iron lamellar	Brinell	HB	90-664	*	*	*	92-326	*
Measuring	graphite GG	Vickers Rockwell	HV HRC	90-698 21-59					
<u> </u>	Cast iron, nodular	Brinell	НВ	95-686	*	*	*	127-364	*
eg	graphite GGG	Vickers	HV	96-724					
Σ	0 - 1 - 1 - 1 - 1 - 1 - 1 - 1 - 1	Rockwell	HRC HB	21-60	00.107	00.104	00.176	19-37	01.107
	Cast aluminium	Brinell Vickers	HV	19-164 22-193	20-187 21-191	20-184 22-196	23-176 22-198	19-168	21-167
	alloys	Rockwell	HRB	24-85				24-86	23-85
	Copper/zinc alloys	Brinell	HB	40-173	*	*	*	*	*
	(brass)	Rockwell	HRB	14-95					
	CuAl/CuSn-alloys	Brinell	HB	60-290	*	*	*	*	*
	(bronze)								
	Wrought copper	Brinell	HB	45-315	*	*	*	*	*
	alloys, low alloyed	D 1	1 1 100 1000	N = 7				NO	NE
	Surface		rade class ISO 1302	N7				N9	N5
ţ	preparation		ss depth R _t (µm / µinch)					30 / 1200 7 / 275	2.5 / 100
<u>=</u>	Minimum sample		hness R _a (µm / µinch) hape (kg / lbs)	2 / 80 5 / 11				15 / 33	0.4 / 16
Ξ	mass	On solid supp		2 / 4.5				5 / 11	0.5 / 1.1
<u>e</u>	IIIass	Coupled on p		0.05 / 0.2				0.5 / 1.1	0.02 / 0.045
Έ.	Minimum sample	Uncoupled (n		25 / 0.98				70 / 2.73	15 / 0.59
Requirements	thickness	Coupled (mm		3 / 0.12				10 / 0.4	1 / 0.04
			thickness (mm / inch)	0.8 / 0.03					0.2 / 0.008
Test Piece	Indentation size on	-	Diameter (mm / inch)	0.54 / 0.021				1.03 / 0.04	0.38 / 0.015
<u>ē</u>	test surface	30 HRC	Depth (µm / µinch)	24 / 960				53 / 2120	12 / 480
_	tost suriace		Diameter (mm / inch)	0.45 / 0.017				0.9 / 0.035	0.32 / 0.012
St		With 600 HV, 55 HRC	Depth (µm / µinch)	17 / 680				41 / 1640	8 / 2560
E		With 800 HV,		0.35 / 0.013				1171040	0.30 / 0.011
		63 HRC	Depth (µm / µinch)	10 / 400					7 / 280
		<u> </u>	Dopar (pin / pinon)	10 / 700					1, 1, 200

*Custom conversion curve / correlation







Specially For Thin Parts

Particularly suited for scratchsensitive and polished parts or on thin parts, profiles and pipes with a wall thickness that is below 2 mm (0.08").



Suits Various Sample Geometries

Unique measuring clamp and support feet are available for the probe allowing tests to be carried out on various geometries.



Broad Hardness Scales Coverage

Measurements in HRC and HV with automatic integrated conversions to HB, HRA, HRB and many more common scales in compliance to ASTM E140 and ISO 18265.

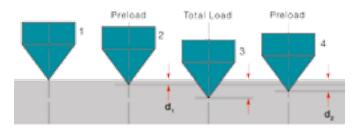


For Any Environment

The Equotip 550 Portable Rockwell can be utilized for on-site, factory and lab environment with almost no limitation.

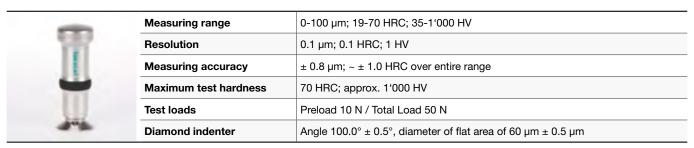
The Rockwell Measuring Principle

The test principle of the Equotip Portable Rockwell follows the traditional Rockwell static test method. During measurements with the Equotip Portable Rockwell Probe, a diamond indenter is forced into the test piece using a precisely controlled force. The indentation depth of the diamond is continuously measured while a load is applied and released. From the indentation depths d_1 and d_2 recorded at two defined loads, the difference is calculated: $\Delta = d_2 - d_1$. This is traditionally referred to as plastic deformation.





Equotip® Portable Rockwell Probe and Accessories





Round standard foot (magnetic) Ideal for flat parts, and test locations more than 10 mm from an edge.



Tripod footDesigned for tests that require accurate positioning (welds, heat-affected zones).



Special feet RZ 18-70 and 70-∞ Designed for curved test pieces such as cylindrical parts, tubes, pipes.

The Portable Rockwell Measuring Clamp





for flat parts





Support Z2 for thin cylindical parts, wires, bolts



Support Z4+28 for tubes and pipes over Ø 28 mm



Ordering Information

Bestsellers

Prepacked Units

All units include: Equotip Touchscreen incl. Battery, Power Supply, USB Cable, Surface Roughness Comparator Plate, DVD with Software, Documentation, Carrying Strap and Carrying Case

Equotip® 550



356 10 001

For flexible probe configuration and for existing owners of Equotip and Equostat 3 probes

Equotip® 550 Leeb D



356 10 002 Additionally includes Equotip Leeb Impact Device D, Impact Device Cable, Test Block ~775 HLD / ~56 HRC, Coupling Paste, Cleaning Brush

Equotip® 550 Leeb G



356 10 003
Additionally includes
Equotip Leeb Impact Device
G, Impact Device Cable,
Test Block ~570 HLG /
~340 HB, Coupling Paste,
Cleaning Brush

Equotip[®] 550 Portable Rockwell



356 10 004 Additionally includes Equotip Portable Rockwell Probe 50 N, Probe Cable, Test Block ~62 HRC

Impact Devices & Probes

Equotip Leeb Impact Devices		
356 00 500	Equotip Leeb Impact Device C	
356 00 100	Equotip Leeb Impact Device D	
356 00 110	Equotip Leeb Impact Device DC	
356 00 120	Equotip Leeb Impact Device DL	
356 00 400	Equotip Leeb Impact Device E	
356 00 300	Equotip Leeb Impact Device G	
356 00 200	Equotip Leeb Impact Device S	

Equotip Portable Rockwell Probe		
356 00 600	Equotip Portable Rockwell Probe 50 N	

Accessories

Equotip Leeb Accessories		
353 03 000	Set of Support Rings	
356 00 080	Equotip Impact Device Cable 1.5 m (5 ft)	
353 00 086	Equotip Impact Device Cable 5 m (15 ft)	

Equotip Portable Rockwell Accessories		
354 01 200	Equotip Portable Rockwell Measuring Clamp	
354 01 130	Equotip Portable Rockwell Tripod	
354 01 250	Equotip Portable Rockwell Special Foot RZ 18 - 70	
354 01 253	Equotip Portable Rockwell Special Foot RZ 70 - ∞	



Ordering Information

Test Blocks

Equotip Lea	eb Test Blocks Calibrated by Proceq
357 11 500	Equotip Test Block C, ~565 HLC / <220 HB
357 12 500	Equotip Test Block C, ~665 HLC / ~325 HB
357 13 500	Equotip Test Block C, ~835 HLC / ~56 HRC
357 11 100	Equotip Test Block D/DC, <500 HLD / <220 HB
357 12 100	Equotip Test Block D/DC, ~600 HLD / ~325 HB
357 13 100	Equotip Test Block D/DC, ~775 HLD / ~56 HRC
357 13 105	Equotip Test Block D/DC, ~775 HLD, one side
357 11 120	Equotip Test Block DL, <710 HLDL / <220 HB
357 12 120	Equotip Test Block DL, ~780 HLDL /~325 HB
357 13 120	Equotip Test Block DL, ~890 HLDL / ~56 HRC
357 13 400	Equotip Test Block E, ~740 HLE / ~56 HRC
357 14 400	Equotip Test Block E, ~810 HLE / ~63 HRC
357 31 300	Equotip Test Block G, <450 HLG / <200 HB
357 32 300	Equotip Test Block G, ~570 HLG / ~340 HB
357 13 200	Equotip Test Block S, ~815 HLS / ~56 HRC
357 14 200	Equotip Test Block S, ~875 HLS / ~63 HRC

Equotip Port	able Rockwell Test Blocks
357 41 100	Equotip Portable Rockwell Test Block ~20 HRC, ISO 6508-3 HRC Calibration
357 42 100	Equotip Portable Rockwell Test Block ~45 HRC, ISO 6508-3 HRC Calibration
357 44 100	Equotip Portable Rockwell Test Block ~62 HRC, ISO 6508-3 HRC Calibration

Additional Test Block Calibrations

Factory Calibrations by Proceq		
357 10 109	Additional Calibration HLD / HLDC	
357 10 129	Additional Calibration HLDL	
357 10 209	Additional Calibration HLS	
357 10 409	Additional Calibration HLE	
357 10 509	Additional Calibration HLC	
357 30 309	Additional Calibration HLG	

By Accredited Institutes		
357 90 909	Additional Calibration HL (DIN 50156-3)	
357 90 919	Additional Calibration HB (ISO 6506-3)	
357 90 929	Additional Calibration HV (ISO 6507-3)	
357 90 939	Additional Calibration HR (ISO 6508-3)	

By Accredited Institutes	
357 90 918	Additional Calibration HB (ISO 6506-3)
357 90 928	Additional Calibration HV (ISO 6507-3)

Service and Support

Proceq is committed to providing the best support and service available in the industry through the Proceq certified service centers worldwide. This results in a complete support for Equotip by means of our global service and support facilities.

Warranty Information

Each instrument is backed by the standard Proceq warranty and extended warranty options.

- » Electronic portion of the instrument: 24 months
- » Mechanical portion of the instrument: 6 months

Subject to change without notice. All information contained in this documentation is presented in good faith and believed to be correct. Proceq SA makes no warranties and excludes all liability as to the completeness and/or accuracy of the information. For the use and application of any product manufactured and/or sold by Proceq SA explicit reference is made to the particular applicable operating instructions.



A Story of Success - Over more than 60 Years



Market Leader

Proceq SA was established in 1954 in Zurich, Switzerland and is a leading manufacturer of high precision portable instruments for a wide range of applications such as concrete, metal, rock, paper and composites. Find out more on the Proceq history

INVENTOR OF LEEB

INDUSTRY STANDARD

NON-DESTRUCTIVE



INVENTED IN 1975

PORTABLE

LEEB & ROCKWELL



Worldwide Local Support

Our team of dedicated experts are available to advise you on our instruments and their applications. In addition you may take further benefits from our instructional videos, evaluation tools, online webinars and of course our live seminars globally.

ISO 9001

Swiss Made

Proceq instruments are developed, designed and manufactured in Switzerland. Since 1994, Proceq has been certified to the ISO 9001 standards that guarantee highest quality of processes, products and services.

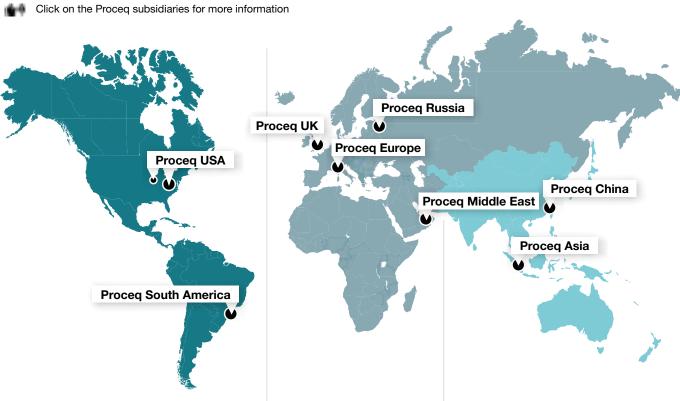


Experience

Proceq has been a proud innovator in the field of portable non-destructive testing, developing a number of brands that have conquered the inspection industry for decades, such as the Equotip®, Schmidt® Hammers, Pundit®, Profometer® and Carboteq®.







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E-Shop USA



E-Shop Europe



E-Shop Asia



Globally organized seminars to help you learn more about our products and applications. Contact your local representative for further information.

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